Applicant(s)/Patent Under Application/Control No. Reexamination 09/480,861 YONEZAWA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2621 Shawn S. An **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 08-2001 Vaios, Christos I. 340/541 US-6,271,752 B1 Α US-В US-С US-D US-Ε US-F US-G US-Н US-1 US-J US-Κ L US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.